Notice of References Cited Application/Control No. 10/709,908 Examiner CHIA-WEI A. CHEN Applicant(s)/Patent Under Reexamination IDE, HIROYUKI Page 1 of 1

U.S. PATENT DOCUMENTS

| | 0. | | | | | |
|---|--|--|-----------------|------------------|----------------|--|
| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification | |
| * | Α | US-2003/0156209 | 08-2003 | YANAI, TOSHIKAZU | 348/272 | |
| | В | US- | | | | |
| | O | US- | | | | |
| | ם | US- | | | | |
| | ш | US- | | | | |
| | F | US- | | | | |
| | G | US- | | | | |
| | Ι | US- | | i = +ii | | |
| | _ | US- | | | | |
| | J | US- | | | | |
| | K | US- | | | | |
| | Ш | US- | | | | |
| | М | US- | | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| 6 | R | | | | | |
| | s | | | | | |
| | - | | | | 100 | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.